

Notice of References Cited			Application/Control No. 10/563,756	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
Examiner Khanh T. Nguyen			Art Unit 1796	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,399,230	06-2002	Tormey et al.	428/702
*	B	US-4,251,397	02-1981	Scheiber, David H.	252/519.34
*	C	US-6,428,914	08-2002	Nagano et al.	313/509
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0132810	07-1984	EPO	Hormadaly, Jacob	C03C 03/64
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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